


<b>Search Notes</b>  	<b>Application/Control No.</b>  10534103	<b>Applicant(s)/Patent Under Reexamination</b>  RANSOME ET AL.
	<b>Examiner</b>  Cehic, Kenan	<b>Art Unit</b>  2616

SEARCHED			
Class	Subclass	Date	Examiner
370	252,248,241,449,	11/28/2007	KC
709	224	11/28/2007	KC

SEARCH NOTES		
Search Notes	Date	Examiner
Inventorship search	11/27/2007	KC
Consulted with SPE Kwang Yao	11/27/2007	KC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner